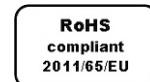


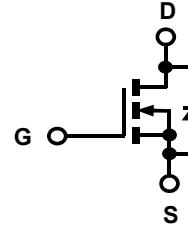
ICE10N65FP N-Channel Enhancement Mode MOSFET


**HALOGEN
FREE**

Product Summary			
I_D	$T_A=25^\circ\text{C}$	9.5A	Max
$V_{(\text{BR})\text{DSS}}$	$I_D=250\mu\text{A}$	650V	Min
$r_{\text{DS}(\text{on})}$	$V_{GS}=10\text{V}$	0.35	Typ
Q_g	$V_{DS}=480\text{V}$	41nC	Typ

Features

- Low $r_{\text{DS}(\text{on})}$
- Ultra Low Gate Charge
- High dv/dt capability
- High Unclamped Inductive Switching (UIS) capability
- High peak current capability
- Increased transconductance performance
- Optimized design for high performance power systems



ICEMOS AND ITS SISTER COMPANY 3D SEMI OWN THE FUNDAMENTAL PATENTS FOR SUPERJUNCTION MOSFETS. THE MAJORITY OF THESE PATENTS HAVE 17 to 20 YEARS OF REMAINING LIFE. THIS PORTFOLIO HAS GRANTED PATENTS ISSUED IN USA, CHINA, KOREA, JAPAN, TAIWAN & EUROPE.

Maximum ratings at $T_j=25^\circ\text{C}$, unless otherwise specified

**T0220 Full-PAK
Isolated (T0-220)**
**1=Gate, 2=Drain,
3=Source**

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current ^a	I_D	$T_c=25^\circ\text{C}$ $T_c=100^\circ\text{C}$	9.5 5.9	A
Pulsed drain current ^b	$I_{D, \text{pulse}}$	$T_c=25^\circ\text{C}$	28.5	A
Avalanche energy, single pulse	E_{AS}	$I_D=8.3\text{A}$	340	mJ
Avalanche current, repetitive	I_{AR}	limited by $T_{j\text{max}}$	5	A
MOSFET dv/dt ruggedness	dv/dt	$V_{DS}=480\text{V}$, $I_D=9.5\text{A}$, $T_j=125^\circ\text{C}$	50	V/ns
Gate source voltage	V_{GS}	static	± 20	V
		AC ($f>1\text{Hz}$)	± 30	
Power dissipation	P_{tot}	$T_c=25^\circ\text{C}$	35	W
Operating and storage temperature	T_j , T_{stg}		-55 to +150	°C
Mounting torque ^c		M 2.5 screws	50	Ncm

^a Limited by $T_{j\text{max}}$

^b Pulse width tp limited by $T_{j\text{max}}$

^c When mounted on 1inch square 2oz copper clad FR-4

Parameter	Symbol	Conditions	Values			Unit
			Min	Typ	Max	

Thermal characteristics

Thermal resistance, junction-case °C	R_{thJC}		-	-	3.5	°C/W
Thermal resistance, junction-ambient °C	R_{thJA}	leaded	-	-	80	
Soldering temperature, wave soldering only allowed at leads	T_{sold}	1.6mm (0.063in.) from case for 10 s	-	-	260	°C

Electrical characteristics at $T_j=25^\circ\text{C}$, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0\text{ V}, I_D=250\mu\text{A}$	650	675	-	V
Gate threshold voltage	$V_{GS(\text{th})}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	2.1	3	3.9	
Zero gate voltage drain current	I_{DSS}	$V_{DS}=650\text{V}, V_{GS}=0\text{V}, T_j=25^\circ\text{C}$	-	0.1	1	μA
		$V_{DS}=650\text{V}, V_{GS}=0\text{V}, T_j=150^\circ\text{C}$	-	20	-	
Gate source leakage current	I_{GSS}	$V_{GS}=\pm 20\text{ V}, V_{DS}=0\text{V}$	-	-	100	nA
Drain-source on-state resistance	$r_{DS(\text{on})}$	$V_{GS}=10\text{V}, I_D=4.75\text{A}, T_j=25^\circ\text{C}$	-	0.35	0.38	Ω
		$V_{GS}=10\text{V}, I_D=4.75\text{A}, T_j=150^\circ\text{C}$	-	0.99	-	
Gate resistance	R_G	$f=1\text{ MHZ}, \text{open drain}$	-	4.8	-	Ω

Dynamic characteristics

Input capacitance	C_{iss}	$V_{GS}=0\text{ V}, V_{DS}=25\text{ V}, f=1\text{ MHz}$	-	1277	-	pF
Output capacitance	C_{oss}		-	296	-	
Reverse transfer capacitance	C_{rss}		-	2	-	
Transconductance	g_{fs}	$V_{DS}>2*I_D*R_{DS}, I_D=4.75\text{A}$	-	12	-	S
Turn-on delay time	$t_{d(on)}$	$V_{DS}=380\text{V}, V_{GS}=10\text{V}, I_D=9.5\text{A}, R_G=4\Omega$ (External)	-	29	-	ns
Rise time	t_r		-	40	-	
Turn-off delay time	$t_{d(off)}$		-	79	-	
Fall time	t_f		-	25	-	



Parameter	Symbol	Conditions	Values			Unit
			Min	Typ	Max	

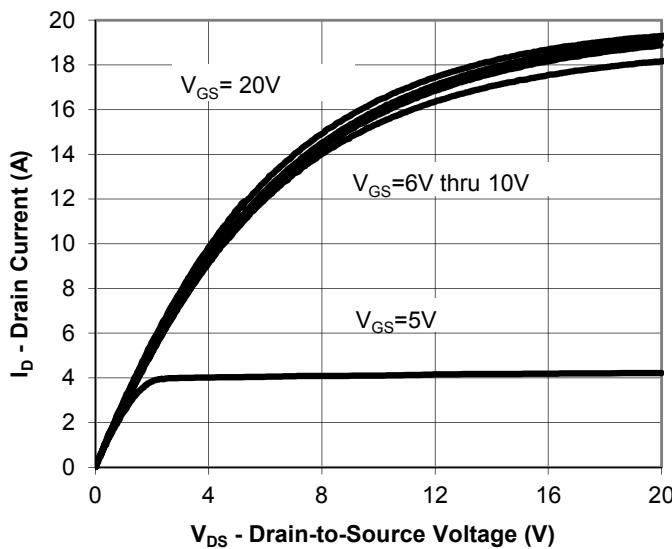
Gate charge characteristics

Gate to source charge	Q_{gs}	$V_{DS}=480\text{ V}, I_D=9.5\text{A}, V_{GS}=0\text{ to }10\text{ V}$	-	7.1	-	nC
Gate to drain charge	Q_{gd}		-	16.3	-	
Gate charge total	Q_g		-	41	-	
Gate plateau voltage	$V_{plateau}$		-	5.4	-	V

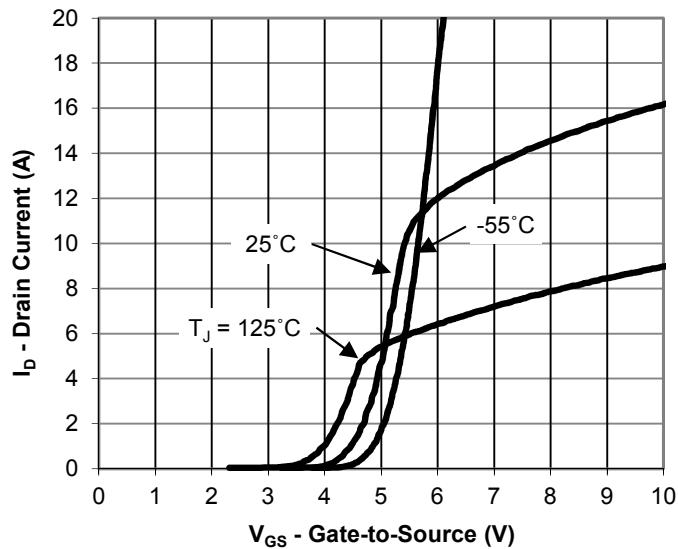
Reverse Diode

Continuous forward current	I_S	$V_{GS}=0\text{V}$	-	-	10	A
Diode forward voltage	V_{SD}	$V_{GS}=0\text{V}, I_S=I_F$	-	0.9	1.2	V
Reverse recovery time	t_{rr}	$V_{RR}=50\text{V}, I_S=I_F, d_{IF}/dt=100\text{ A}/\mu\text{s}$	-	301	-	ns
Reverse recovery charge	Q_{rr}		-	4.4	-	μC
Peak reverse recovery current	I_{rm}		-	27	-	A

Output Characteristics

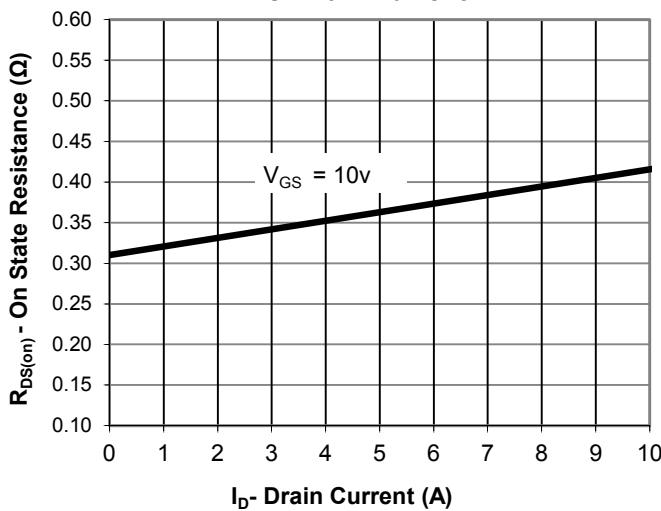


Transfer Characteristics

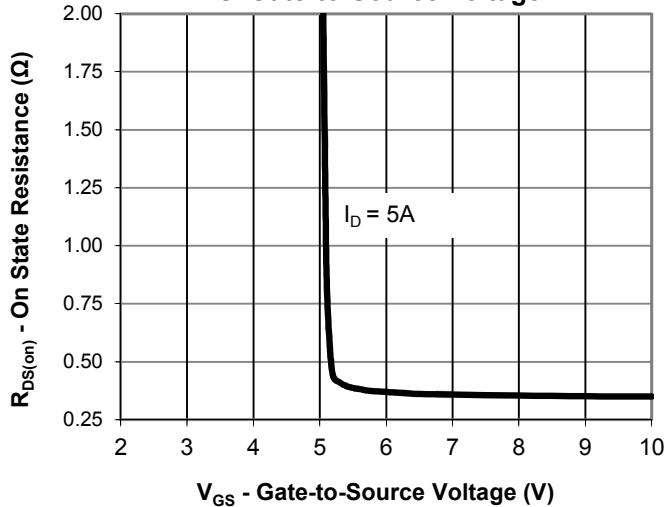




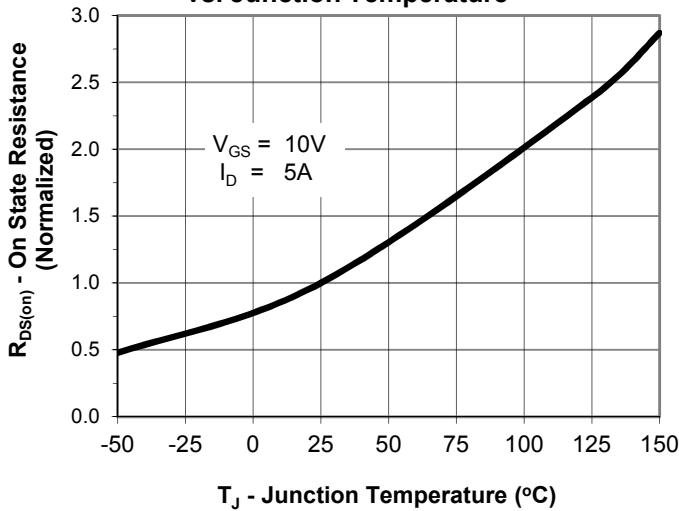
Drain-Source On-State Resistance
vs. Drain Current



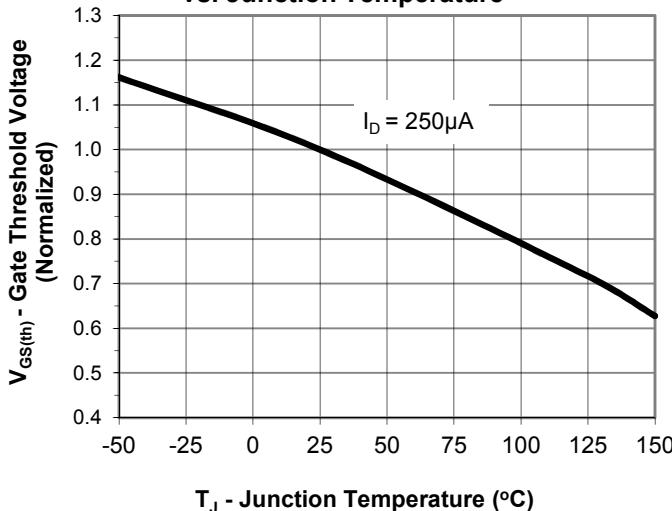
Drain-Source On-State Resistance
vs. Gate-to-Source Voltage



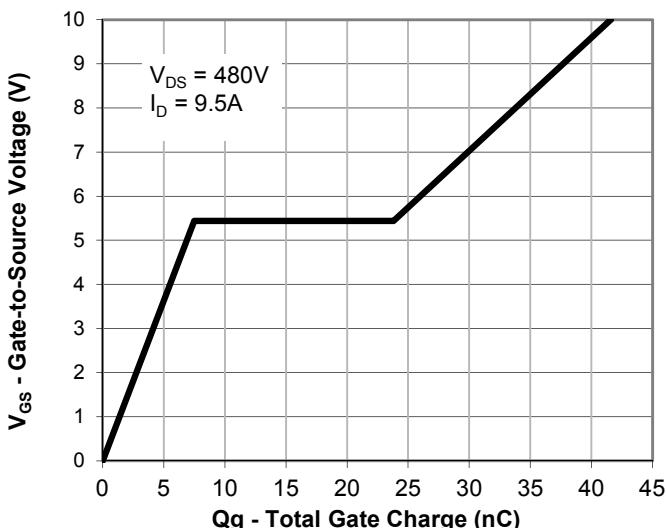
Drian-Source On State Resistance
vs. Junction Temperature



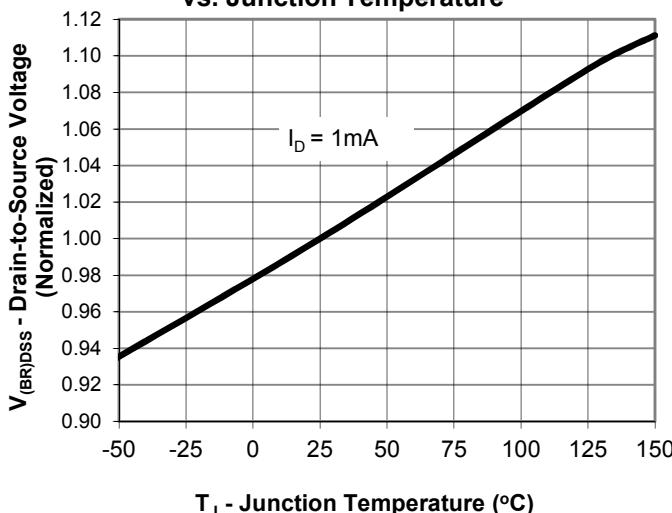
Gate Threshold Voltage
vs. Junction Temperature



Gate Charge



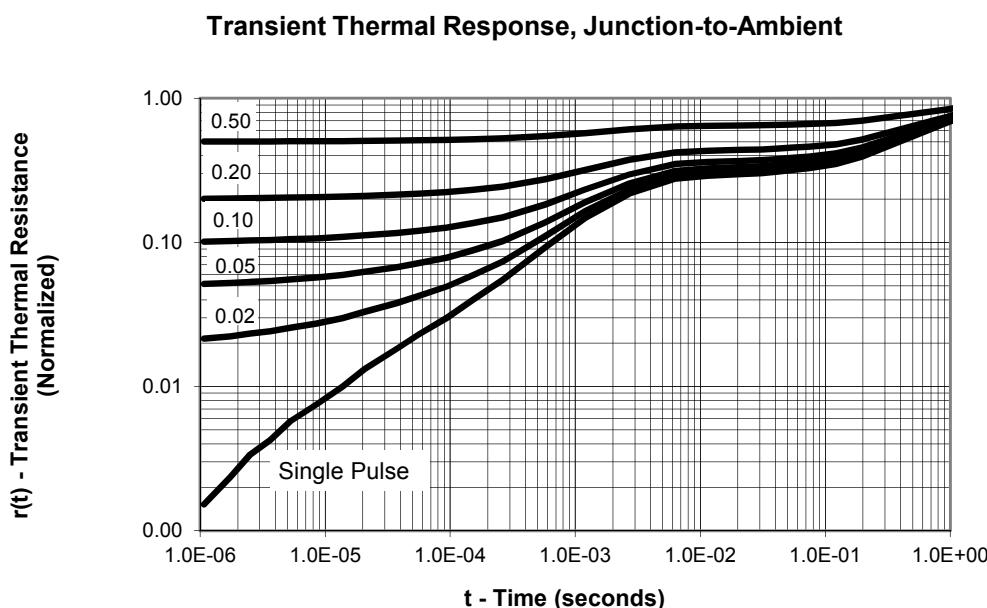
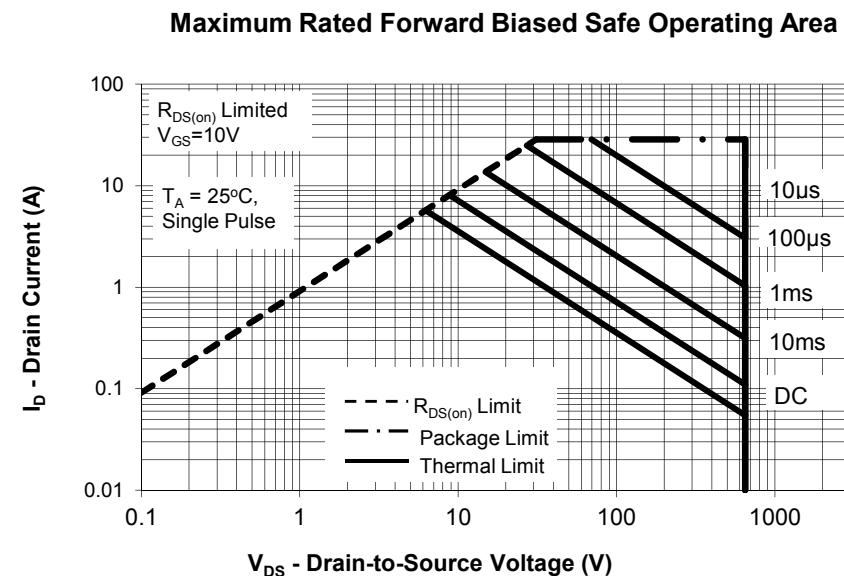
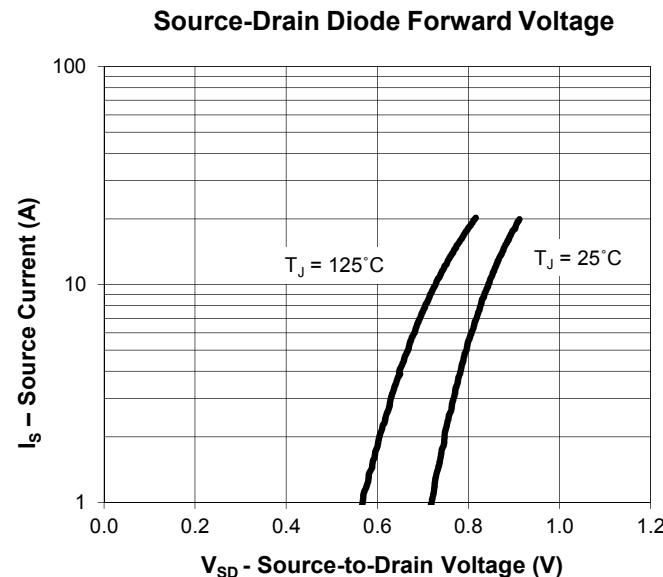
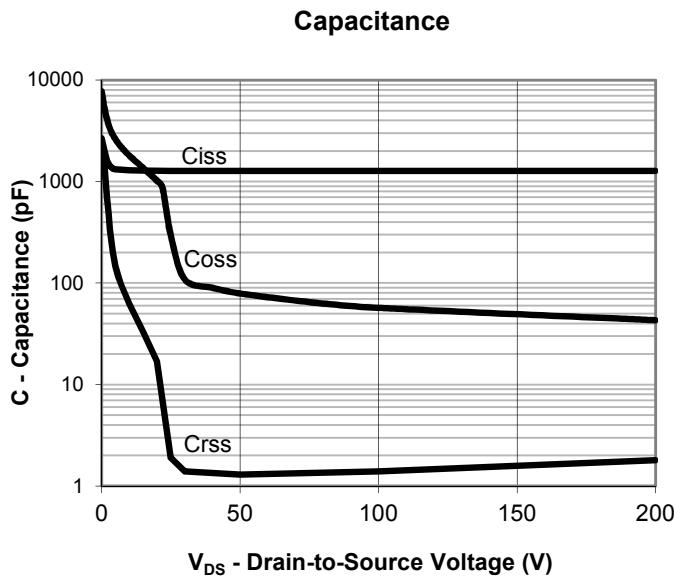
Drain-toSource Breakdown Voltage
vs. Junction Temperature





Icemos
Cooler than cool

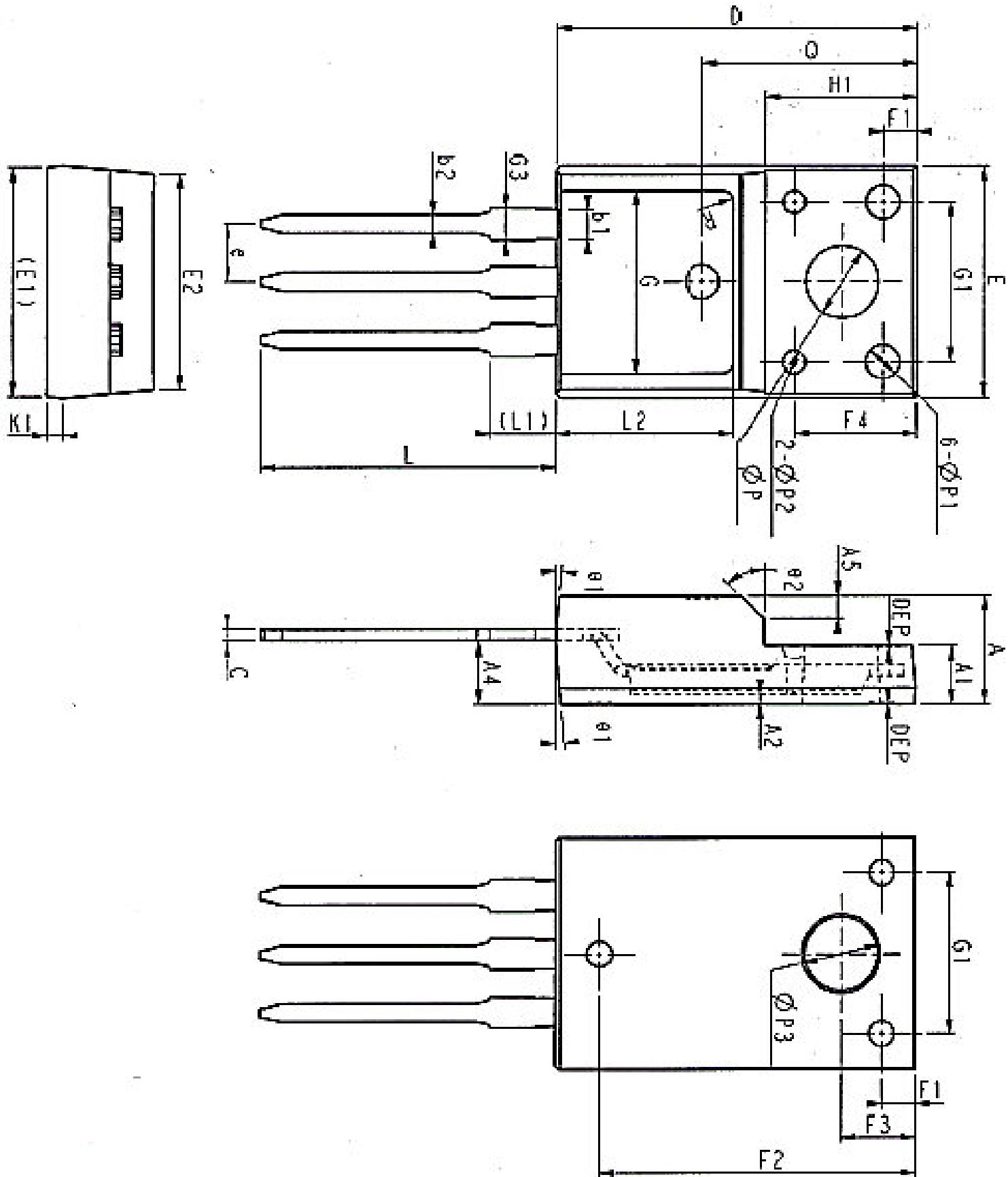
ICE10N65FP





Icemos
Cooler than cool

ICE10N65FP





COMMON DIMENSIONS						
SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX
E	9.63	10.19	10.75	0.38	0.40	0.42
E1	9.94	10.04	10.14	0.39	0.40	0.40
E2	9.36	9.46	9.56	0.37	0.37	0.38
A	4.30	4.60	4.90	0.17	0.18	0.19
A1	2.34	2.77	3.20	0.092	0.11	0.126
A2	0.43	0.87	1.30	0.017	0.03	0.051
A4	2.51	2.72	2.93	0.10	0.11	0.12
A5	1.00REF			0.39REF		
c	0.33	0.54	0.75	0.013	0.021	0.030
D	15.67	15.9	16.13	0.617	0.626	0.635
Q	9.4REF			0.370REF		
H1	6.7REF			0.264REF		
E	2.54BSC			0.100BSC		
ΦP	3.18REF			0.125REF		
L	12.78	13.25	13.72	0.50	0.52	0.54
L1	2.83	3.25	3.67	0.11	0.13	0.14
L2	7.70	7.80	7.90	0.30	0.31	0.31
ΦP1	1.4	1.5	1.6	0.055	0.059	0.063
ΦP2	1.15	1.2	1.25	0.045	0.047	0.049
ΦP3	3.45REF			0.136REF		
θ1	3°	5°	7°	3°	5°	7°
θ2	-	45°	-	-	45°	-
DEP	0.05	0.10	0.15	0.002	0.004	0.006
F1	1.0	1.50	2.0	0.039	0.059	0.079
F2	13.8	13.90	14.0	0.543	0.547	0.551
F3	3.20	3.30	3.40	0.126	0.130	0.134
F4	5.30	5.40	5.50	0.209	0.213	0.217
G	7.80	8.00	8.20	0.307	0.315	0.323
G1	6.05	6.58	7.10	0.238	0.259	0.280
G3	1.25	1.35	1.45	0.049	0.053	0.057
b1	1.23	1.31	1.38	0.048	0.051	0.054
b2	0.61	0.78	0.94	0.024	0.031	0.037
K1	0.65	0.70	0.75	0.026	0.028	0.030
R	0.50REF			0.020REF		

ICEMOS SUPERJUNCTION PATENT PORTFOLIO

ICEMOS GRANTED PATENTS

**US7,429,772
US7,439,178
US7,446,018
US7,579,607
US7,723,172
US7,795,045
US7,846,821
US7,944,018
US8,012,806
US8,030,133**

3D SEMI PATENTS LICENSED TO ICEMOS

**US7,041,560B2
US7,023,069B2
US7,364,994
US7,227,197B2
US7,304,944B2
US7,052,982B2
US7,339,252
US7,410,891
US7,439,583
US7,227,197B2
US6,635,906
US6,936,867
US7,015,104
US9,109,110
US7,271,067
US7,354,818
US7,052,982,
US7,199,006B2**

Note: additional patents in China, Korea, Japan, Taiwan, Europe have also been granted to IceMOS and 3D Semi for Superjunction MOSFETs with 70 additional Patent applications in process in the USA and the above listed countries.



Marking Information

YY = Last two digits of the year

WW = Work week calendar on Icemos
subcon assembly & test house

***** = Initial for Icemos subcon
assembly and test house

XXXXXX = Lot ID

ICE10N65 = ICE is Icemos logo and
10N65 is a designated device part
number

